

<b>Notice of References Cited</b>	Application/Control No. 10/758,596		Applicant(s)/Patent Under Reexamination NISHIKAWA ET AL.	
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*	B	US-6,271,902	08-2001	Ogura et al.	349/106
*	C	US-6,309,486	10-2001	Kawaguchi et al.	156/67
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#### NON-PATENT DOCUMENTS

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